

Notice of References Cited

Application/Control No.

10/552,837

Applicant(s)/Patent Under
Reexamination
BEYER ET AL.

Examiner

CHUN CHEUNG

Art Unit

3728

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-3,681,092	08-1972	Titchenal et al	426/412
*	B	US-5,417,040	05-1995	Davoren, Gerrard A.	53/455
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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